

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it displays a valid OMB control number.

Substitute for form 1449/PTO				<i>Complete if Known</i>	
				Application Number	10/558,434
				Filing Date	November 29, 2005
				First Named Inventor	Sam-Chul HA
				Art Unit	2471
				Examiner Name	Albert T. Chou
Sheet	1	of	1	Attorney Docket Number	7950.036.00

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
AA		US 4,928,245	05-22-1990	Moy et al.	
AB		US 5,551,001	08-27-1996	Cohen et al.	
AC		US 5,794,037	08-11-1998	David W. Young	
AD		US 5,808,885	09-15-1998	Dew et al.	
AE		US 5,859,847	01-12-1999	Dew et al.	
AF		US 6,078,952	06-20-2000	Fielding et al.	
AG		US 6,615,243 B1	09-02-2003	Megeid et al.	
AH		US 6,854,053 B2	02-08-2005	Burkhardt et al.	
AI		US 6,934,740 B1	08-23-2005	Lawande et al.	
AJ		US 7,058,722 B2	06-06-2006	Ikami et al.	
AK		US 2002/0118696 A1	08-29-2002	Yukinori Suda	
AL		US 2002/0120763 A1	08-29-2002	Miloushev et al.	
AM		US 2002/0165989 A1	11-07-2002	Hiroshi Etoh	
AN		US 2002/0193144 A1	12-19-2002	Belski et al.	
AO		US 2003/0051053 A1	03-13-2003	Vasko et al.	
AP		US 2003/0054809 A1	03-20-2003	Bridges et al.	
AQ		US 2004/0111490 A1	06-10-2004	Im et al.	
AR		US 2004/0205309 A1	10-14-2004	Naoki Watanabe	
AS		US 2006/0047677 A1	03-02-2006	Lin et al.	
AT		US 2008/0222325 A1	09-11-2008	Ishino et al.	

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)			
BA					

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the application number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ²
	CA				

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	Date Considered
--------------------	-----------------